

Search Notes

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Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

HON ET AL.

Art Unit

1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST: JPO,EPO,DERWENT,USPATFULL,U SPGPUBS,OCRBACKFILE	12/5/2005	PL
Inventor name search PALM/EAST	12/5/2005	PL